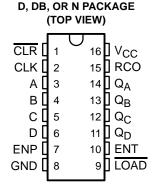
- Internal Look-Ahead Circuitry for Fast Counting
- Carry Output for N-Bit Cascading
- Fully Synchronous Operation for Counting

description

This synchronous, presettable, 4-bit binary counter has internal carry look-ahead circuitry for use in high-speed counting designs. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when



so instructed by the count-enable (ENP, ENT) inputs and internal gating. This mode of operation eliminates the output counting spikes that normally are associated with asynchronous (ripple-clock) counters. However, counting spikes can occur on the ripple-carry (RCO) output. A buffered clock (CLK) input triggers the four flip-flops on the rising (positive-going) edge of CLK.

This counter is fully programmable. That is, it can be preset to any number between 0 and 15. Because presetting is synchronous, a low logic level at the load (\overline{LOAD}) input disables the counter and causes the outputs to agree with the setup data after the next clock pulse, regardless of the levels of ENP and ENT.

The clear function is synchronous, and a low logic level at the clear ($\overline{\text{CLR}}$) input sets all four of the flip-flop outputs to low after the next low-to-high transition of the clock, regardless of the levels of ENP and ENT. This synchronous clear allows the count length to be modified easily by decoding the Q outputs for the maximum count desired. The active-low output of the gate used for decoding is connected to the clear input to synchronously clear the counter to 0000 (LLLL).

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications, without additional gating. This function is implemented by the ENP and ENT inputs and an RCO output. Both ENP and ENT must be high to count, and ENT is fed forward to enable RCO. RCO, thus enabled, produces a high-logic-level pulse while the count is 15 (HHHH). The high-logic-level overflow ripple-carry pulse can be used to enable successive cascaded stages. Transitions at ENP or ENT are allowed, regardless of the level of CLK.

The SN74F163A features a fully independent clock circuit. Changes at ENP, ENT, or $\overline{\text{LOAD}}$ that modify the operating mode have no effect on the contents of the counter until clocking occurs. The function of the counter (whether enabled, disabled, loading, or counting) is dictated solely by the conditions meeting the setup and hold times.

ORDERING INFORMATION

TA	PACK	AGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – N	Tube	SN74F163AN	SN74F163AN
0°C to 70°C	SOIC - D	Tube	SN74F163AD	F163A
0 0 10 70 0		Tape and reel	SN74F163ADR	FIOSA
	SSOP – DB	Tape and reel	SN74F163ADBR	F163A

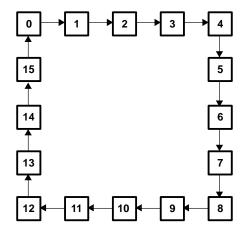
[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



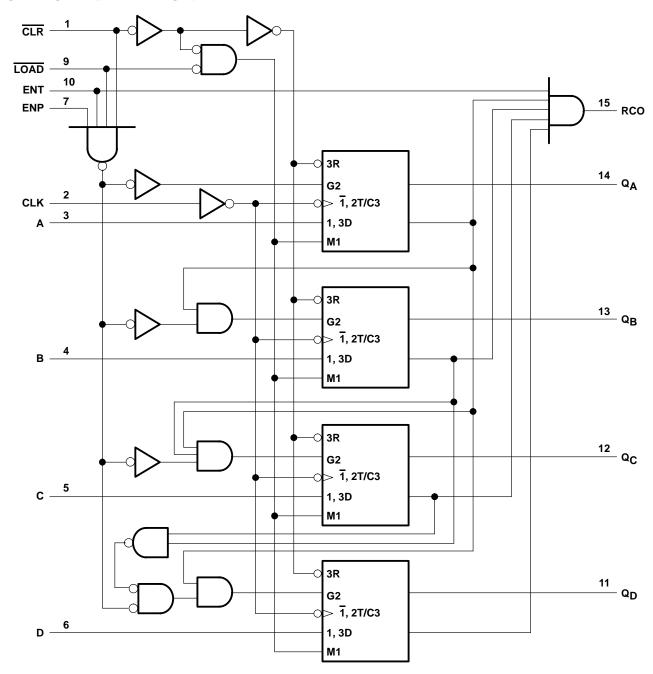
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



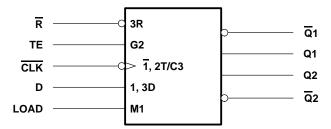
state diagram



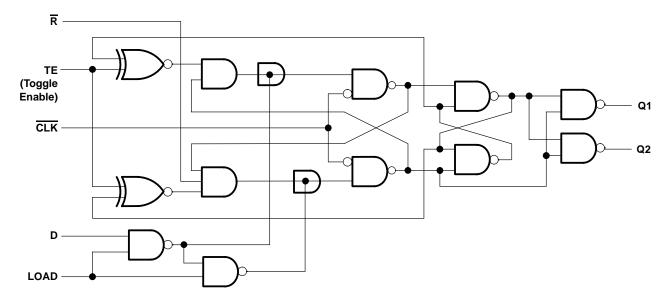
logic diagram (positive logic)



logic symbol, each flip-flop



logic diagram, each flip-flop (positive logic)

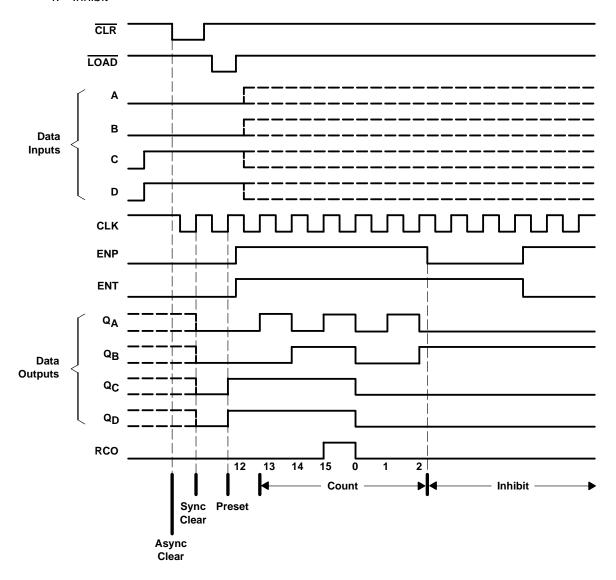




typical clear, preset, count, and inhibit sequences

The following timing sequence is illustrated below:

- 1. Clear outputs to zero
- 2. Preset to binary 12
- 3. Count to 13, 14, 15, 0, 1, and 2
- 4. Inhibit



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}		–0.5 V to 7 V
Input voltage range, V _I (see Note 1)		1.2 V to 7 V
Input current range		30 mA to 5 mA
Voltage range applied to any output in the high	state	0.5 V to V _{CC}
Current into any output in the low state		40 mA
Package thermal impedance, θ _{JA} (see Note 2)	: D package	73°C/W
-	DB package	82°C/W
	N package	67°C/W
Storage temperature range, T _{stq}		65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V_{IL}	Low-level input voltage			8.0	V
l _{IK}	Input clamp current			-18	mA
ЮН	High-level output current			-1	mA
loL	Low-level output current			20	mA
TA	Operating free-air temperature	0		70	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TE	ST CONDITIONS	MIN	TYP‡	MAX	UNIT
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2	V
VOH		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -1 \text{ mA}$	2.5	3.4		V
		$V_{CC} = 4.75 V$,	$I_{OH} = -1 \text{ mA}$	2.7			V
VOL		$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 20 \text{ mA}$		0.3	0.5	V
II		$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1	mA
lн		V _{CC} = 5.5 V,	V _I = 2.7 V			20	μΑ
	ENP, CLK, A, B, C, D					- 0.6	
Ι _Ι L	ENT, LOAD	$V_{CC} = 5.5 V,$	$V_{I} = 0.5 V$			- 1.2	mA
	CLR					- 1.2	
los§		$V_{CC} = 5.5 \text{ V},$	V _O = 0	-60		-150	mA
Icc		V _{CC} = 5.5 V			37	55	mA

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.



NOTES: 1. The input voltage ratings may be exceeded provided the input current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.

[§] Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

				V _{CC} =	= 5 V, 25°C	MIN	MAX	UNIT
				MIN	MAX			
fclock	Clock frequency			0	100	0	90	MHz
	Pulse duration	CLK high or low (loading)		5		5		
t _w		CLK (counting)	High	4		4		ns
		CLK (counting)	Low	6		7		
		Data before CLK↑	High or low	5		5		
		LOAD and CLR before CLK↑	High	11		11.5		
t _{su}	Setup time	LOAD and CLR before CLK	Low	8.5		9.5		ns
		ENP and ENT before CLK↑	High	11		11.5		
		ENP and ENT before CLK	Low	5		5		
		Data after CLK↑	High or low	2		2		
4.	I lold time	10AD - 110LD - (1-1-0LK)	High	2		2		
^t h	Hold time	LOAD and CLR after CLK↑	Low	0		0		ns
		ENP and ENT after CLK↑	High or low	0		0		

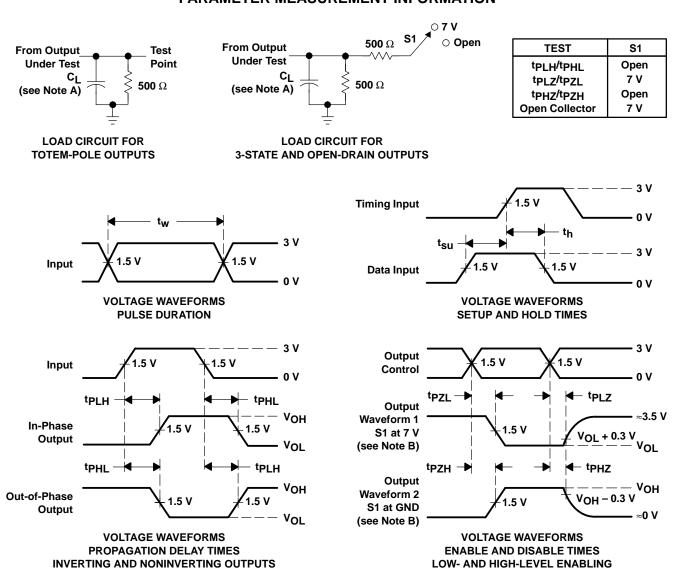
switching characteristics (see Note 4)

PARAMETER	FROM (INPUT)	$ \begin{array}{c c} \text{TO} & \text{$C_L=50$ PF,} \\ \text{(OUTPUT)} & \text{$R_L=500$ Ω,} \\ \text{$T_A=25^{\circ}$C} & \text{$T_A=MIN$ TO MAX} \\ \end{array} $			$R_L = 500 \Omega$, $T_A = 25^{\circ}C$		PF, 0Ω,) MAX†	UNIT
£			MIN	TYP	MAX	MIN	MAX	N41.1-
f _{max}			100	120		90		MHz
^t PLH	CLK (LOAD high)	Any Q	2.7	5.1	7.5	2.7	8.5	ns
^t PHL	OLK (LOAD High)	Ally Q	2.7	7.1	10	2.7	11	110
^t PLH	CLK (LOAD low)	Any 0	3.2	5.6	8.5	3.2	9.5	ns
^t PHL	CLK (LOAD low)	Any Q	3.2	5.6	8.5	3.2	9.5	115
^t PLH	CLK	B00	4.2	9.6	14	4.2	15	
^t PHL	OLK	RCO	4.2	9.6	14	4.2	15	ns
t _{PLH}	ENT	RCO	1.7	4.1	7.5	1.7	8.5	no
^t PHL	LINI	ROU	1.7	4.1	7.5	1.7	8.5	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 4: Load circuits and waveforms are shown in Figure 1.



PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns, duty cycle = 50%.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



www.ti.com 11-Nov-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN74F163AD	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	0 to 70	F163A
SN74F163ADR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	F163A
SN74F163ADR.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	F163A
SN74F163AN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN74F163AN
SN74F163AN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN74F163AN
SN74F163ANE4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN74F163AN

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PACKAGE OPTION ADDENDUM

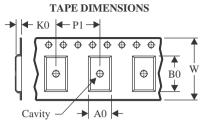
www.ti.com 11-Nov-2025

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74F163ADR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025



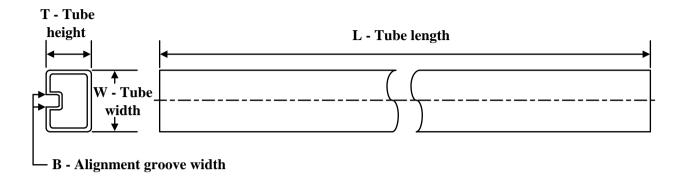
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN74F163ADR	SOIC	D	16	2500	340.5	336.1	32.0	

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74F163AN	N	PDIP	16	25	506	13.97	11230	4.32
SN74F163AN	N	PDIP	16	25	506	13.97	11230	4.32
SN74F163AN.A	N	PDIP	16	25	506	13.97	11230	4.32
SN74F163AN.A	N	PDIP	16	25	506	13.97	11230	4.32
SN74F163ANE4	N	PDIP	16	25	506	13.97	11230	4.32
SN74F163ANE4	N	PDIP	16	25	506	13.97	11230	4.32

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025